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April 1<sup>st</sup>, 2010 Renesas Electronics Corporation

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## MOS FIELD EFFECT TRANSISTOR $\mu$ PA2793AGR

### SWITCHING N- AND P-CHANNEL POWER MOS FET

#### **DESCRIPTION**

The  $\mu$ PA2793AGR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

#### **FEATURES**

• Low on-state resistance

N-channel R<sub>DS(on)1</sub> = 15 m $\Omega$  MAX. (V<sub>GS</sub> = 10 V, I<sub>D</sub> = 3.5 A)

 $R_{DS(on)2} = 23 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, Ip} = 3.5 \text{ A)}$ 

P-channel RDS(on)1 = 26 m $\Omega$  MAX. (VGS = -10 V, ID = -3.5 A)

 $R_{DS(on)2} = 36 \text{ m}\Omega \text{ MAX}. \text{ (Vgs} = -4.5 \text{ V, Ip} = -3.5 \text{ A)}$ 

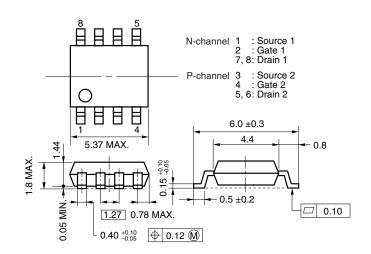
· Low input capacitance

N-channel C<sub>iss</sub> = 2200 pF TYP.

P-channel C<sub>iss</sub> = 2200 pF TYP.

- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

#### PACKAGE DRAWING (Unit: mm)

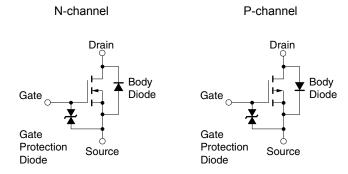


#### ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE	
μPA2793AGR-E1-AT Note				
μPA2793AGR-E2-AT Note	Pure Sn	Tape 2500 p/reel	Power SOP8	

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

#### **EQUIVALENT CIRCUITS**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (V <sub>GS</sub> = 0 V)	V <sub>DSS</sub> 40		-40	V
Gate to Source Voltage (VDS = 0 V)	V <sub>GSS</sub>	±20	∓20	V
Drain Current (DC)	I <sub>D(DC)</sub>	±7	<b>∓7</b>	А
Drain Current (pulse) Note1	I <sub>D</sub> (pulse)	±28	∓28	А
Total Power Dissipation (1 unit) Note2	P <sub>T1</sub>	1.7		W
Total Power Dissipation (2 units) Note2	P <sub>T2</sub>	2	W	
Channel Temperature	Tch	1	°C	
Storage Temperature	T <sub>stg</sub>	−55 to +150		°C
Single Avalanche Current Note3	las	7	-7	А
Single Avalanche Energy Note3	Eas	4	mJ	

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

- 2. Mounted on ceramic substrate of 2000 mm<sup>2</sup> x 1.6 mm
- 3. Starting Tch = 25°C, VdD = 20 V, Rg = 25  $\Omega$ , L = 100  $\mu$ H, Vgs = 20  $\rightarrow$  0 V



#### **ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)**

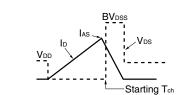
#### N-channel

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μΑ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	٧
Forward Transfer Admittance Note	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.5 A	4	8.5		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.5 A		12	15	mΩ
	RDS(on)2	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.5 A		16.5	23	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V,		2200		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V,		320		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		190		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 3.5 A,		9.2		ns
Rise Time	tr	V <sub>GS</sub> = 10 V,		22		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 0 Ω		54		ns
Fall Time	tf			10		ns
Total Gate Charge	Q <sub>G</sub>	I <sub>D</sub> = 7 A,		40		nC
Gate to Source Charge	Q <sub>GS</sub>	V <sub>DD</sub> = 32 V,		6		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = 10 V		12		nC
Body Diode Forward Voltage Note	V <sub>F(S-D)</sub>	I <sub>F</sub> = 7 A, V <sub>GS</sub> = 0 V		0.8	1.5	V
Reverse Recovery Time	trr	I <sub>F</sub> = 7 A, V <sub>GS</sub> = 0 V,		27		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		21		nC

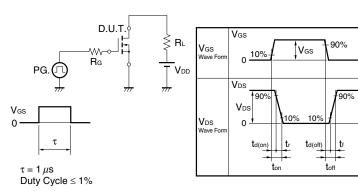
Note Pulsed

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

## $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \ \Omega \\ \text{VGS} = 20 \rightarrow 0 \ \text{V} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{Rg} \\ \text{So} \\ \text{M} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{N} \\ \text{M} \end{array}$



#### **TEST CIRCUIT 2 SWITCHING TIME**



#### **TEST CIRCUIT 3 GATE CHARGE**



#### P-channel

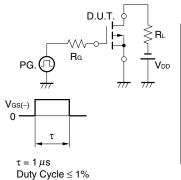
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = 0 V			-10	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V			∓10	μΑ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA	-1.0	-1.7	-2.5	V
Forward Transfer Admittance Note	yfs	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -3.5 A	5	11		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.5 A		21	26	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -3.5 A		24	36	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V,		2200		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V,		350		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		260		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = -20 V, I <sub>D</sub> = -3.5 A,		10		ns
Rise Time	tr	V <sub>GS</sub> = -10 V,		18		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 0 Ω		150		ns
Fall Time	tr			26		ns
Total Gate Charge	Q <sub>G</sub>	ID = -7 A,		45		nC
Gate to Source Charge	Qgs	V <sub>DD</sub> = -32 V,		5.2		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = -10 V		12		nC
Body Diode Forward Voltage Note	V <sub>F(S-D)</sub>	I <sub>F</sub> = 7 A, V <sub>GS</sub> = 0 V		0.84	1.5	V
Reverse Recovery Time	trr	I <sub>F</sub> = -7 A, V <sub>GS</sub> = 0 V,		54		ns
Reverse Recovery Charge	Qrr	$di/dt = -50 \text{ A}/\mu\text{s}$		25		nC

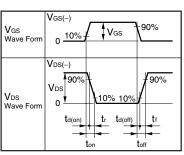
Note Pulsed

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $V_{GS} = -20 \rightarrow 0 \text{ V}_{m}$ $V_{DD}$ $V_{DD}$

#### **TEST CIRCUIT 2 SWITCHING TIME**



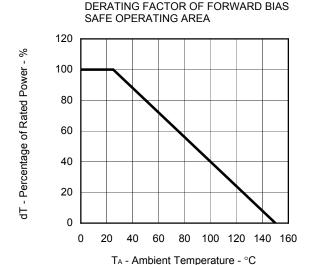


#### **TEST CIRCUIT 3 GATE CHARGE**

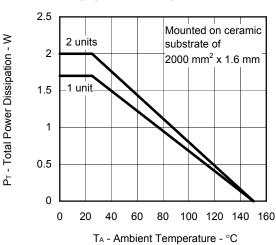
$$\begin{array}{c|c} D.U.T. \\ \hline \\ I_G = -2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array}$$

#### TYPICAL CHARACTERISTICS (TA = 25°C)

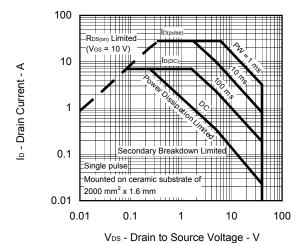
#### (1) N-channel

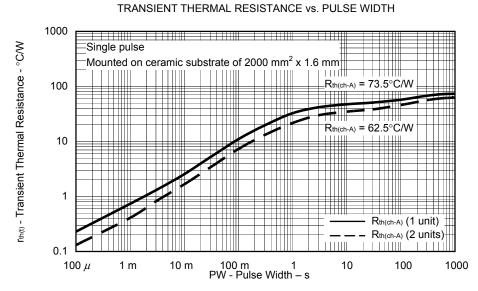


#### TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



#### FORWARD BIAS SAFE OPERATING AREA

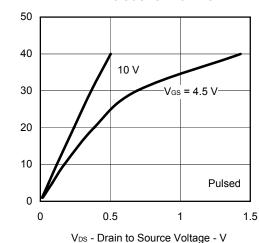




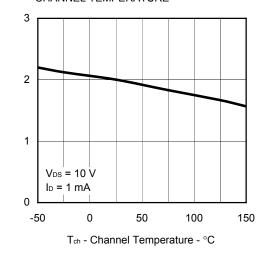
Ib - Drain Current - A

VGS(off) - Gate to Source Cut-off Voltage - V

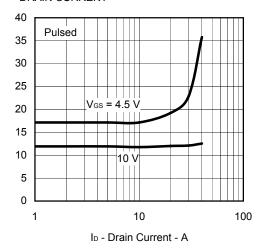
#### DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



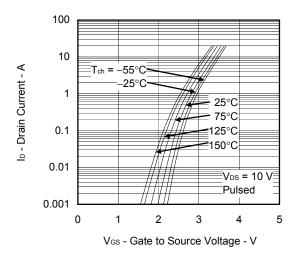
#### GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



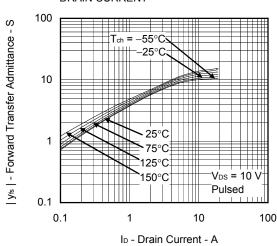
#### DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



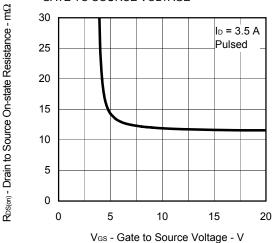
#### FORWARD TRANSFER CHARACTERISTICS



#### FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



#### DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

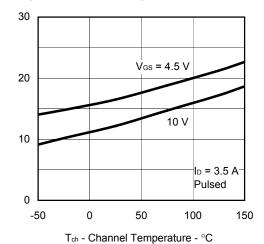


R<sub>DS(m)</sub> - Drain to Source On-state Resistance - mΩ

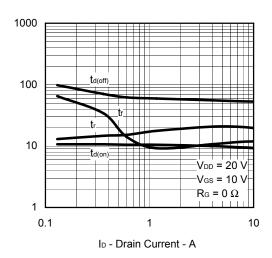
 $R_{DS(\sigma I)}$  - Drain to Source On-state Resistance -  $m\Omega$ 

ta(on), tr, ta(off), tr - Switching Time - ns

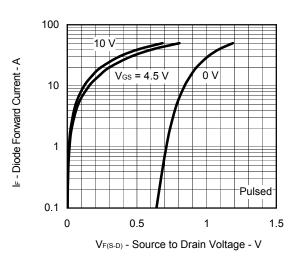
#### DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



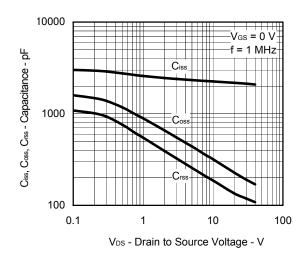
#### SWITCHING CHARACTERISTICS



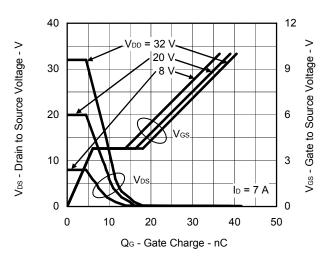
#### SOURCE TO DRAIN DIODE FORWARD VOLTAGE



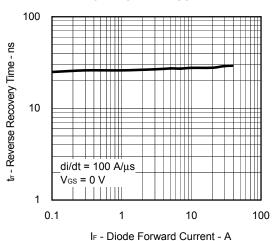
#### CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



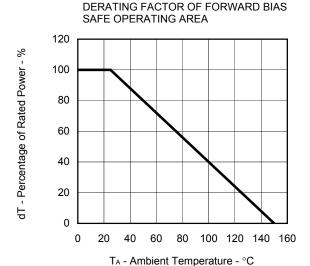
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



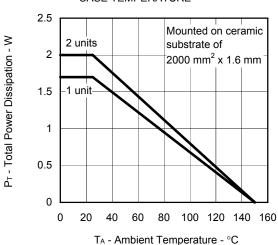
REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



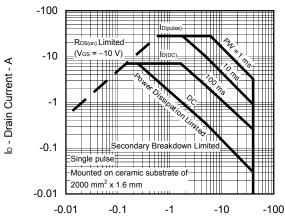
#### (2) P-channel



#### TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

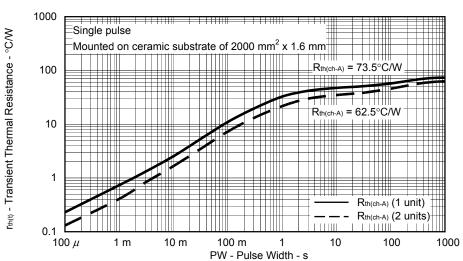


#### FORWARD BIAS SAFE OPERATING AREA



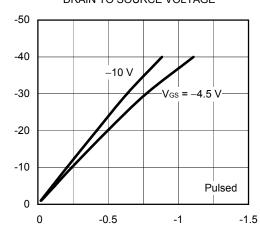
V<sub>DS</sub> - Drain to Source Voltage - V

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

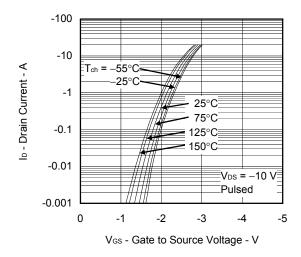


lo - Drain Current - A

#### DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

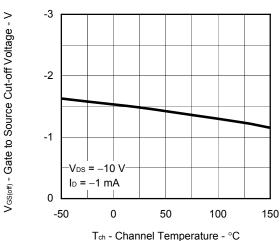


#### FORWARD TRANSFER CHARACTERISTICS

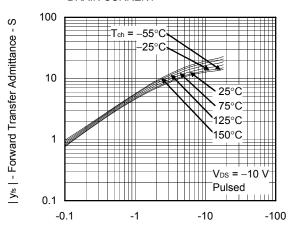


GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

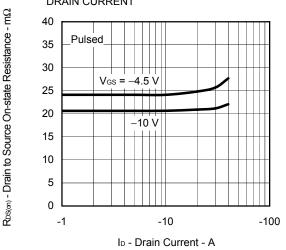
VDS - Drain to Source Voltage - V



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

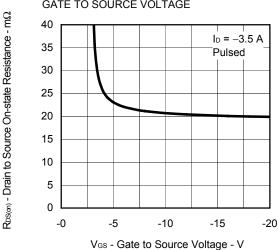


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

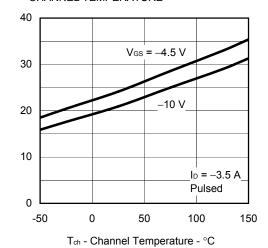
ID - Drain Current - A



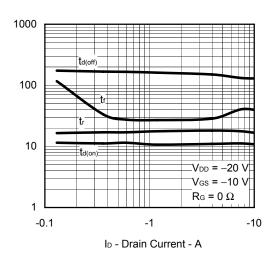
 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - Drain to Source On-state Resistance -  $m\Omega$ 

ta(on), tr, ta(off), tr - Switching Time - ns

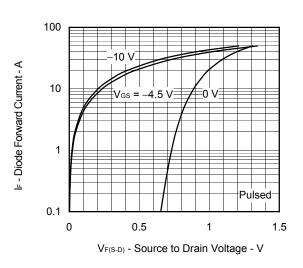
#### DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



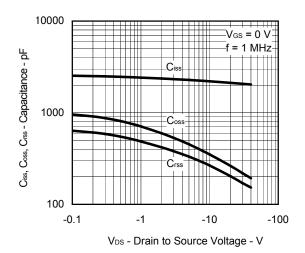
#### SWITCHING CHARACTERISTICS



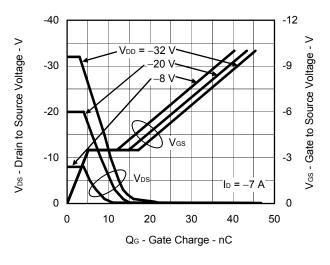
#### SOURCE TO DRAIN DIODE FORWARD VOLTAGE



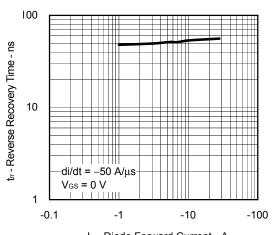
#### CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



#### DYNAMIC INPUT/OUTPUT CHARACTERISTICS

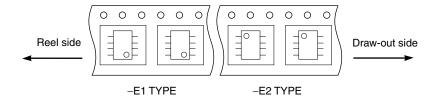


#### REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

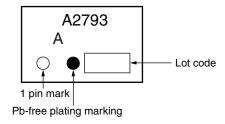


#### TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



#### **MARKING INFORMATION**



#### RECOMMENDED SOLDERING CONDITIONS

The  $\mu$ PA2793AGR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Maximum temperature (Package's surface temperature): 260°C or below	IR60-00-3
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

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